

**Search Notes**

Application/Control No.

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Examiner

TAN X. DINH

Applicant(s)/Patent under  
Reexamination

URUSHIHARA ET AL.

Art Unit

2627

**SEARCHED**

Class	Subclass	Date	Examiner
720	626 619		
720	645		
720	624		
720	623		
720	620		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
Interference Search History Printout)		2/15/2007	T.D

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (see search history printout)	2/15/2007	T.D